

L Number	Hits	Search Text	DB	Time stamp
-	1253	714/6.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:37
-	1288	711/170.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:37
-	847	711/147.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:37
-	1591	((second or multiple or dual or plural or several) near3 board) with memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:37
-	0	multi?board adj solid?state adj memory	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:37
-	0	multi?board adj ((solid?state) or (solid adj state)) adj memory	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:37
-	0	20020108075.URPN.	USPAT	2004/08/20 08:37
-	278	711/147.ccls. and (module)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:37
-	464	711/170.ccls. and (module)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:37
-	362	714/6.ccls. and (module)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:37
-	2491	(security with memory with (module or card or board))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
-	0	((defect) adj (table)) with (factory or manufacture or manufacturing) same (update) same (non-volatile)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
-	0	((defect) adj (table or list)) same (factory or manufacture or manufacturing) same (update) same (non-volatile)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38

	1	((defect or fault or broken) with (table or list)) same (factory or manufacture or manufacturing or creation or create)) same (non-volatile) same (memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
	4	(((defect or fault) adj (table or list or map)) same (factory or manufacture or manufacturing or creation or create)) same (non-volatile) same (memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
	5068	(defect or defective or fault or faulty or fail or failed or failing or faulting) with (secondary or second or separate) with (memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
	935	(defect or defective or fault or faulty or fail or failed or failing or faulting) near3(secondary or second or separate) near3 (memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
	0	20020108075.URPN.	USPAT	2004/08/20 08:38
	3	714/6.ccls. and (((second or multiple) adj board) same memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
	24	714/6.ccls. and (((second or multiple or dual or plural) with board) same memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
	15	714/6.ccls. and (((second or multiple or dual or plural or several) near3 board) same memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
	166	((second or multiple or dual or plural or several) near3 board) with memory) and 711/\$.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
	2	multi?board with ((solid?state) or (solid adj state)) with memory	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
	1	2002-656936.NRAN.	DERWENT	2004/08/20 08:38
	2	("5430859").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
	4	("5172338") or ("5297148").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38
	471	714/7.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:38

	324	714/8.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
	814	711/147.ccls. and memory	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
	84	714/6.ccls. and (memory adj module)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
	169	711/170.ccls. and (memory adj module)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
	80	711/147.ccls. and (memory adj module)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 13:03
	278	(714/6.ccls. and (module)) not (714/6.ccls. and (memory adj module))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
	295	(711/170.ccls. and (module)) not (711/170.ccls. and (memory adj module))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
	304	(security with memory with (module or card or board)) same (non-volatile or nonvolatile)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
	198	(711/147.ccls. and (module)) not (711/147.ccls. and (memory adj module))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
	1	((defect) adj (table or list)) same (factory or manufacture or manufacturing) same (non-volatile)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
	1	((defect or fault) adj (table or list)) same (factory or manufacture or manufacturing or creation or create) same (non-volatile) same (memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
	102	((((defect or fault or broken) with (table or list)) same (factory or manufacture or manufacturing or creation or create)) same (memory)) and (non-volatile)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39

		4	((defect) adj (table or list or map)) same (factory or manufacture or manufacturing) same (non-volatile)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
		4	((defect or fault or broken) with (table or list or map)) same (factory or manufacture or manufacturing or creation or create) same (non-volatile) same (memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
		111	((defect or fault or broken) with (table or list or map)) same (factory or manufacture or manufacturing or creation or create) same (memory)) and (non-volatile)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
		8	((defect or fault or broken) with (table or list or map)) same (factory or manufacture or manufacturing or creation or create) same (memory)) and (non-volatile) and (grown with defect with (table or list or map))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39
		72	((defect or fault or broken) with (table or list or map)) same (factory or manufacture or manufacturing or creation or create) same (memory)) and (non-volatile) and ((operation or use or grown) same (fault or broken or defect) with (table or list or map))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 13:19
		19	((defect or defective or fault or faulty or fail or failed or failing or faulting) near3(secondary or second or separate) near3 (memory)) with (non-volatile or nvram or nv or "non volatile")	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 08:39